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Rautio, J.C.;

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Pages:535 - 537

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2 Synthesis of SPICE-compatible broadband electrical models from n-port scattering parameter data

Neumayer, R.; Haslinger, F.; Stelzer, A.; Weigel, R.;

Electromagnetic Compatibility, 2002 IEEE International Symposium on , Volume: 1 , 19-23 Aug. 2002

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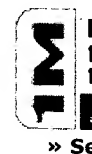
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